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# **Recent Advances in CMOS Integrated Circuits**

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Deadline for manuscript submissions:

closed (15 July 2024)

### **Message from the Guest Editors**

This Special Issue will propose and discuss the progress of CMOS integrated circuits. The Special Issue will introduce the scientific status of the most relevant issues in integrated circuits and find new effective concepts and designs in the field of integrated circuits. The Special Issue will make contributions to circuit design and signal processing research in academic and industrial fields. We invite investigators to submit original research articles to this Special Issue.

Potential submission topics include but are not limited to the following:

- CMOS circuit
- Low dropout regulators
- low-power design of integrated circuits











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### **Editor-in-Chief**

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## **Message from the Editor-in-Chief**

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